



Requires GOLDD technology for mining & minerals mode

Americas

Billerica, MA U.S.A. Phone: +1 978 670-7460 Toll Free: 800 875-1578 (USA)

Fax: +1 978 670-7430 E-mail: niton@thermofisher.com Europe

Munich, Germany Phone: +49 89 3681 380 Fax: +49 89 3681 3830 E-mail: niton.eur@thermofisher.com Asia

Central, Hong Kong
Phone: +852 2869 6669
Fax: +852 2869 6665
E-mail: niton.asia@thermofisher.com

www.thermo.com/niton

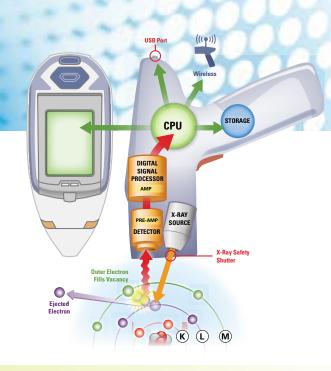


Thermo Scientific Niton XRF Analyzers

Our Niton XRF analyzers, now available with groundbreaking **Geometrically Optimized Large Area Drift Detector** (GOLDD™) technology, bring you the latest in a series of cutting edge, rugged, dependable tools.

- Easy to use promotes user adoption and rapid integration into workflow
- Real-time traceable results with tamperproof data and simple certificate generation
- Nondestructive test doesn't alter or deface sample
- · Lab-quality performance in a handheld instrument
- Light element detection (Mg, Al, Si, P, S) available without helium or vacuum purge
- Lower limits of detection and faster analysis than previously available with handheld XRF
- Rapidly identify, isolate & analyze individual components, then document results with variable spot size and integrated CCD camera option

Satisfied customers representing industries from mining to alloy analysis – including the Consumer Product Safety Commission and the U.S. Environmental Protection Agency – have chosen and trust handheld Niton XRF analyzers.



The Right Analyzer for Your Application



Metal and Alloy Analysis

- Instant, positive grade identification
- Incoming, in-stock, or in-service component testing
- Superior detection limits for tramp/ trace elements
- Rugged design engineered for use in harsh environments
- Excellent light element performance for sorting Al, Ti, and bronze alloys
- · Lost traceability recovered in seconds
- Lower detection limits for Cr, Cu, Ni, and Mo in carbon steel



Toys and Consumer Goods

- Screen child-accessible products for compliance with CPSIA, EN-71, Proposition 65, and other regulations
- Reduce the risk of recall, civil penalties, and legal judgments
- Screen more samples in less time and at lower cost than exclusive reliance on testing laboratories
- Real-time results mean decisions to ship product can be made immediately
- Lead screening can occur in the factory, lab, warehouse, or on the dock
- TestAll™ technology automatically selects the correct analytical mode



RoHS-WEEE Compliance/Halogen-free

- Total Pb, Cd, Hg, Cr, and Br quantified in matter of seconds
- Pass/fail designations provided for each sample, with visual identification of the out of spec elements
- No special calibrations or other user input easy to use by shift personnel
- Easily switch from measuring alloys, to plastics and polymers, to mixed materials – coated leads, Cr coatings, populated PCBs, and BFRs for halogen-free screening
- Ideal for high-reliability systems, finished goods, and packaging



Mining Exploration and Geochemical Analysis

- Rapid survey of soil & outcrops to identify potential drill targets
- Direct screening of core & cuttings for real-time decision making on the drill rig – dynamically drive exploration programs
- On-site delineation of mineralization boundaries
- Results at or below the averages naturally found in the earth's crust
- High sample throughput and increased sample density over traditional lab methods



Environmental Analysis

- Rapid identification of contaminants with analytical range from Mg through U
- Lower detection limits reduce reliance on traditional, fixed-site laboratories
- Improved platform yields faster results; survey larger areas in less time
- Extend-a-PoleTM promotes rapid, ergonomically correct soil surveys
- Wireless GPS integration for elemental mapping with GIS systems

The XRF Analysis Process in Brief

- 1. Primary x-ray energy is produced by the analyzer and directed at the sample surface.
- The primary energy causes inner-shell electrons to be ejected from their orbits in individual atoms.
- Vacancies left by ejected electrons are filled by electrons from outer shells, resulting in emissions of fluorescent x-rays, each of which is characteristic of the element from which it is emitted
- The fluorescent x-rays enter the detector, which registers the individual x-ray events and sends electronic pulses to the preamp.
- **5.** The preamp amplifies the signals and sends them on to the Digital Signal Processor (DSP).
- The DSP collects and digitizes the x-ray events occurring over time, and sends the resulting spectral data to the main CPU for processing.
- The CPU, using various advanced spectral processing algorithms, mathematically analyzes the spectral data to produce a detailed composition analysis.
 - For metal alloy samples, the resulting data is then compared against an internal table or library of min/max specifications to determine an alloy grade or other designation for the tested material.
- The composition data and any resulting identification is then simultaneously displayed on the instrument screen, and stored in memory for later recall and/or download to an external PC.



Part of Thermo Fisher Scientific